Power MOSFET 30 V, 75 A, Single N–Channel, μ8FL

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- DC-DC Converters
- Power Load Switch
- Notebook Battery Management

MAXIMUM RATINGS (T_J = 25° C unless otherwise stated)

Paran	Symbol	Value	Unit		
Drain-to-Source Voltage	V _{DSS}	30	V		
Gate-to-Source Voltage	V _{GS}	±20	V		
Continuous Drain		$T_A = 25^{\circ}C$	I _D	19.4	А
Current $R_{\theta JA}$ (Note 1)		$T_A = 85^{\circ}C$	1	14.5	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	PD	2.16	W
Continuous Drain		T _A = 25°C	I _D	28	А
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		T _A = 85°C		21	
Power Dissipation $R_{\theta JA} \leq 10 \text{ s} \text{ (Note 1)}$	Steady	T _A = 25°C	P _D	4.5	W
Continuous Drain	State	T _A = 25°C	I _D	12.0	А
Current $R_{\theta JA}$ (Note 2)		T _A = 85°C	1	8.9	1
Power Dissipation $R_{\theta JA}$ (Note 2)		$T_A = 25^{\circ}C$	P _D	0.82	W
Continuous Drain		$T_{C} = 25^{\circ}C$	I _D	75	А
Current $R_{\theta JC}$ (Note 1)		T _C = 85°C	1	56	1
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	33	W
Pulsed Drain Current	T _A = 25°0	C, t _p = 10 μs	I _{DM}	174	А
Operating Junction and S	Storage Ten	nperature	Т _Ј , T _{stg}	–55 to +150	°C
Source Current (Body Die	ode)		۱ _S	30	А
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain-to-So (T _J = 25°C, V _{DD} = 50 V, V L = 0.1 mH, R _G = 25 Ω) (E _{AS}	84	mJ		
Lead Temperature for So (1/8" from case for 10 s)	Idering Pur	poses	ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

Surface-mounted on FR4 board using the minimum recommended pad size.

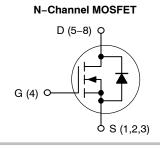
- 3. This is the absolute maximum ratings. Parts are 100% tested at $T_J = 25^{\circ}C$,
- V_{GS} = 10 V, I_L = 29 A, E_{AS} = 42 mJ.



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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30.\/	$3.6~\mathrm{m}\Omega$ @ 10 V	75 A
30 V	5.1 mΩ @ 4.5 V	138



MARKING DIAGRAM 1 5 WDFN8 5 (μ8FL) S CASE 511AB G

4C05 A	Specific Device CodeAssembly Location						
Y	= Year						
WW	= Work Week						
•	= Pb-Free Package						
(Note: Microdot may be in either location)							

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS4C05NTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel
NTTFS4C05NTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ ext{ heta}JC}$	3.8	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	57.8	°C/W
Junction-to-Ambient - Steady State (Note 5)	$R_{\theta JA}$	151.9	-C/W
Junction-to-Ambient – (t \leq 10 s) (Note 4)	$R_{ hetaJA}$	27.6	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μ A		30			V
Drain-to-Source Breakdown Voltage (transient)	V _{(BR)DSSt}	V_{GS} = 0 V, $I_{D(aval)}$ = 12.6 A, T_{case} = 25°C, $t_{transient}$ = 100 ns		34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				11.7		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$			1.0	
		$V_{DS} = 24 V$	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V_{DS} = 0 V, V_{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	= 250 μA	1.3		2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		2.9	3.6	mΩ
		V _{GS} = 4.5 V	I _D = 30 A		4.1	5.1	
Forward Transconductance	9 _{FS}	V _{DS} = 1.5 V, I _E	₀ = 15 A		68		S
Gate Resistance	R _G	T _A = 25°	С		1.0		Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}				1988		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MH	z, V _{DS} = 15 V		1224		pF
Reverse Transfer Capacitance	C _{RSS}				71		
Capacitance Ratio	C _{RSS} /C _{ISS}	V _{GS} = 0 V, V _{DS} = 15	V, f = 1 MHz		0.036		
Total Gate Charge	Q _{G(TOT)}				14.5		
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 30 A			2.9		
Gate-to-Source Charge	Q _{GS}				5.2		nC
Gate-to-Drain Charge	Q _{GD}				5.5		1
Gate Plateau Voltage	V _{GP}				3.1		V
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V; I _D = 30 A			31		nC

Turn–On Delay Time	t _{d(ON)}	11		
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS} = 15 V,	30	
Turn-Off Delay Time	t _{d(OFF)}	$I_{\rm D}$ = 15 A, $R_{\rm G}$ = 3.0 Ω	20	ns
Fall Time	t _f		8.0	

 $\begin{array}{ll} \mbox{6. Pulse Test: pulse width } \le 300 \ \mu \mbox{s, duty cycle } \le 2\%. \\ \mbox{7. Switching characteristics are independent of operating junction temperatures.} \end{array}$

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

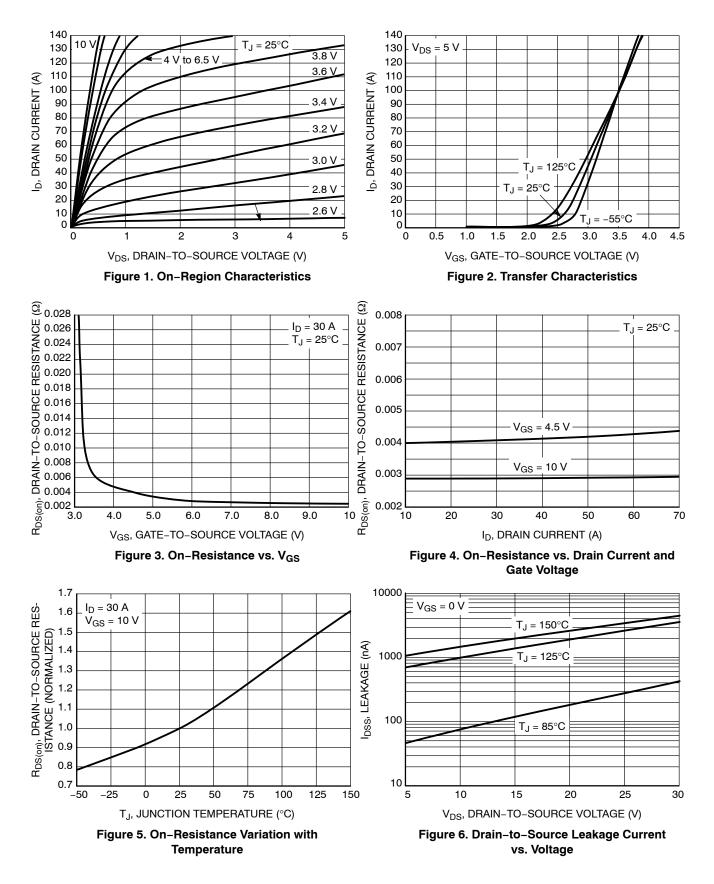
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (No	te 7)						
Turn-On Delay Time	t _{d(ON)}				8.0		
Rise Time	t _r	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			25		ns
Turn-Off Delay Time	t _{d(OFF)}				26		
Fall Time	t _f			5.0			
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V _{SD}	$V_{CS} = 0 V$. $T_J = 25^{\circ}C$			0.77	1.1	
		V _{GS} = 0 V, I _S = 10 A	T _J = 125°C		0.62		V
Reverse Recovery Time	t _{RR}				42.4		
Charge Time	t _a	V _{GS} = 0 V, dIS/dt = 100 A/µs, I _S = 30 A			21.1		ns
Discharge Time	t _b				21.3		
Reverse Recovery Charge	Q _{RR}			34.4		nC	

6. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

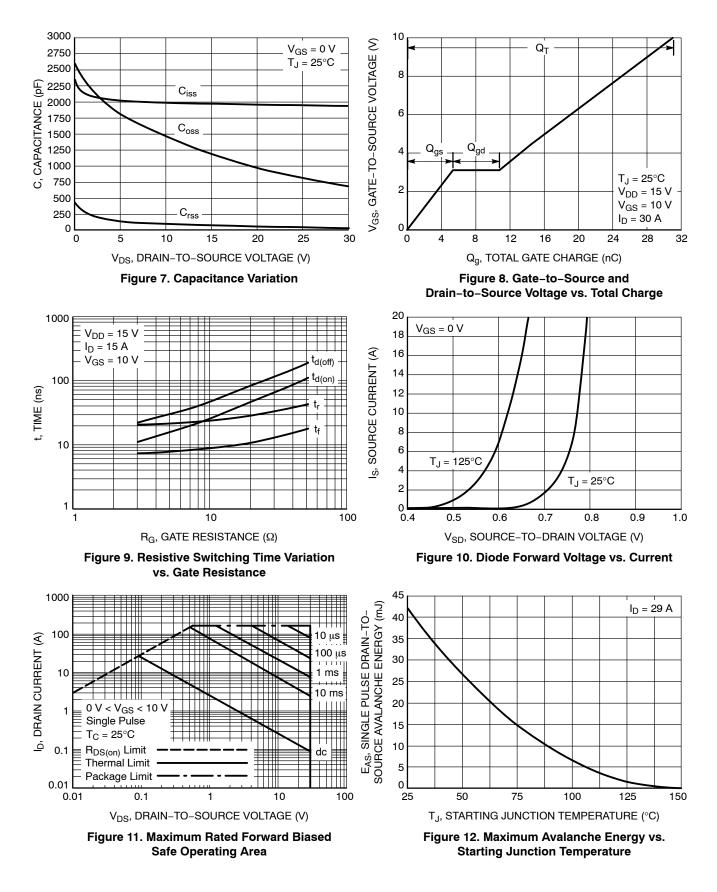
7. Switching characteristics are independent of operating junction temperatures.

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

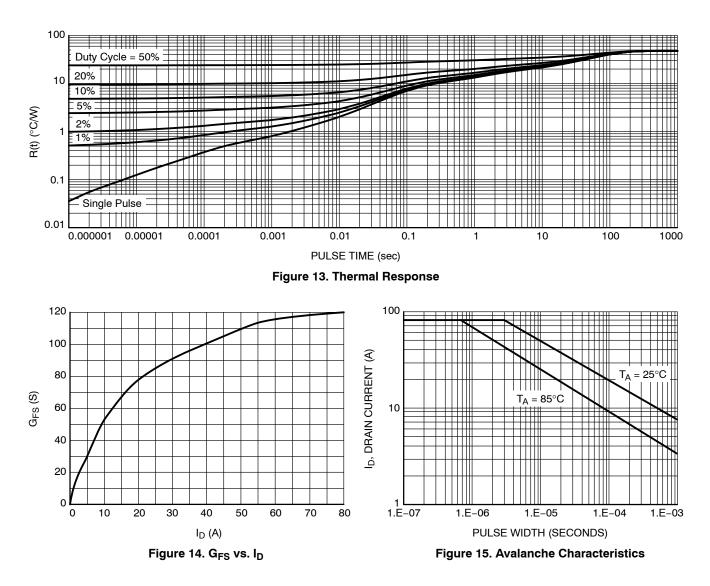
TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

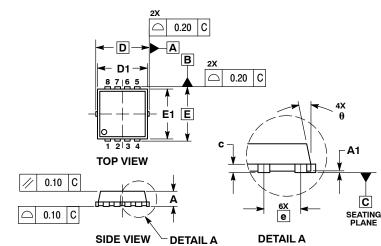


TYPICAL CHARACTERISTICS



PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P CASE 511AB **ISSUE D**

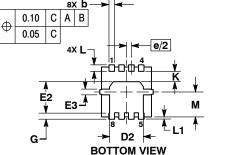


NOTES

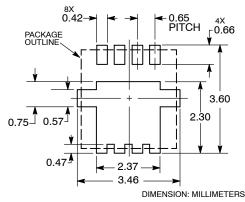
DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.

3. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH RRS.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC		0	.130 BSC)	
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
Е		3.30 BSC		0)		
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е		0.65 BSC			0.026 BS0	2	
G	0.30	0.41	0.51	0.012	0.016	0.020	
к	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	



SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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